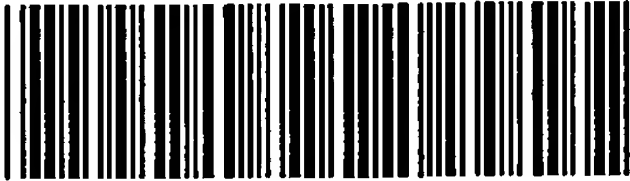


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/670,380	LEE, SANG-HYUK	
	Examiner	Art Unit	
	Tai Duong	2871	

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Class	Subclass	Date	Examiner
349	40, 42	1/21/2007	TD
	141, 187		
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324	770		
438	30		
445	24		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB text search, 01/21/2007, see interference printout		1/21/2007	TD

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM TDB) see search history printout	1/21/2007	TD